

RF Power Field Effect Transistor

N-Channel Enhancement-Mode Lateral MOSFET

Designed for CDMA base station applications with frequencies from 700 to 1000 MHz. Can be used in Class AB and Class C for all typical cellular base station modulation formats.

- Typical Single-Carrier W-CDMA Performance: $V_{DD} = 28$ Volts, $I_{DQ} = 800$ mA, $P_{out} = 33$ Watts Avg., IQ Magnitude Clipping, Channel Bandwidth = 3.84 MHz, Input Signal PAR = 7.5 dB @ 0.01% Probability on CCDF.

Frequency	G_{ps} (dB)	η_D (%)	Output PAR (dB)	ACPR (dBc)
920 MHz	20.1	34.6	6.3	-37.2
940 MHz	20.0	34.3	6.3	-37.3
960 MHz	19.8	34.2	6.3	-37.4

- Capable of Handling 10:1 VSWR, @ 32 Vdc, 940 MHz, 120 Watts CW Output Power (3 dB Input Overdrive from Rated P_{out}), Designed for Enhanced Ruggedness
- Typical P_{out} @ 1 dB Compression Point ≈ 120 Watts CW

880 MHz

- Typical Single-Carrier W-CDMA Performance: $V_{DD} = 28$ Volts, $I_{DQ} = 800$ mA, $P_{out} = 33$ Watts Avg., IQ Magnitude Clipping, Channel Bandwidth = 3.84 MHz, Input Signal PAR = 7.5 dB @ 0.01% Probability on CCDF.

Frequency	G_{ps} (dB)	η_D (%)	Output PAR (dB)	ACPR (dBc)
865 MHz	20.8	35.0	6.2	-37.1
880 MHz	20.8	35.0	6.2	-37.5
895 MHz	20.6	34.8	6.2	-38.0

Features

- 100% PAR Tested for Guaranteed Output Power Capability
- Characterized with Series Equivalent Large-Signal Impedance Parameters and Common Source S-Parameters
- Internally Matched for Ease of Use
- Integrated ESD Protection
- Greater Negative Gate-Source Voltage Range for Improved Class C Operation
- Designed for Digital Predistortion Error Correction Systems
- Optimized for Doherty Applications
- 225°C Capable Plastic Package
- RoHS Compliant
- In Tape and Reel. R3 Suffix = 250 Units per 32 mm, 13 inch Reel.

Table 1. Maximum Ratings

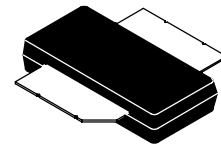
Rating	Symbol	Value	Unit
Drain-Source Voltage	V_{DSS}	-0.5, +70	Vdc
Gate-Source Voltage	V_{GS}	-6.0, +10	Vdc
Operating Voltage	V_{DD}	32, +0	Vdc
Storage Temperature Range	T_{stg}	-65 to +150	°C
Case Operating Temperature	T_C	150	°C
Operating Junction Temperature (1,2)	T_J	225	°C

1. Continuous use at maximum temperature will affect MTTF.

2. MTTF calculator available at <http://www.freescale.com/rf>. Select Software & Tools/Development Tools/Calculators to access MTTF calculators by product.

MRF8S9120NR3

**865-960 MHz, 33 W AVG., 28 V
 SINGLE W-CDMA
 LATERAL N-CHANNEL
 RF POWER MOSFET**



**CASE 2021-03, STYLE 1
 OM-780-2
 PLASTIC**

Table 2. Thermal Characteristics

Characteristic	Symbol	Value (1,2)	Unit
Thermal Resistance, Junction to Case Case Temperature 76°C, 33 W CW, 28 Vdc, I _{DQ} = 800 mA, 960 MHz Case Temperature 76°C, 120 W CW, 28 Vdc, I _{DQ} = 800 mA, 960 MHz	R _{θJC}	0.62 0.51	°C/W

Table 3. ESD Protection Characteristics

Test Methodology	Class
Human Body Model (per JESD22-A114)	2 (Minimum)
Machine Model (per EIA/JESD22-A115)	A (Minimum)
Charge Device Model (per JESD22-C101)	IV (Minimum)

Table 4. Moisture Sensitivity Level

Test Methodology	Rating	Package Peak Temperature	Unit
Per JESD22-A113, IPC/JEDEC J-STD-020	3	260	°C

Table 5. Electrical Characteristics (T_A = 25°C unless otherwise noted)

Characteristic	Symbol	Min	Typ	Max	Unit
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Off Characteristics

Zero Gate Voltage Drain Leakage Current (V _{DS} = 70 Vdc, V _{GS} = 0 Vdc)	I _{DSS}	—	—	10	μAdc
Zero Gate Voltage Drain Leakage Current (V _{DS} = 28 Vdc, V _{GS} = 0 Vdc)	I _{DSS}	—	—	1	μAdc
Gate-Source Leakage Current (V _{GS} = 5 Vdc, V _{DS} = 0 Vdc)	I _{GSS}	—	—	1	μAdc

On Characteristics

Gate Threshold Voltage (V _{DS} = 10 Vdc, I _D = 460 μAdc)	V _{GS(th)}	1.4	2.2	2.9	Vdc
Gate Quiescent Voltage (V _{DD} = 28 Vdc, I _D = 800 mAdc, Measured in Functional Test)	V _{GS(Q)}	2.3	3.1	3.8	Vdc
Drain-Source On-Voltage (V _{GS} = 10 Vdc, I _D = 2 Adc)	V _{DS(on)}	0.1	0.2	0.3	Vdc

Functional Tests ⁽³⁾ (In Freescale Test Fixture, 50 ohm system) V_{DD} = 28 Vdc, I_{DQ} = 800 mA, P_{out} = 33 W Avg., f = 960 MHz, Single-Carrier W-CDMA, IQ Magnitude Clipping, Input Signal PAR = 7.5 dB @ 0.01% Probability on CCDF. ACPR measured in 3.84 MHz Channel Bandwidth @ ±5 MHz Offset.

Power Gain	G _{ps}	19.0	19.8	22.0	dB
Drain Efficiency	η _D	33.0	34.2	—	%
Output Peak-to-Average Ratio @ 0.01% Probability on CCDF	PAR	6.0	6.3	—	dB
Adjacent Channel Power Ratio	ACPR	—	-37.4	-36.4	dBc
Input Return Loss	IRL	—	-20	-12	dB

Typical Broadband Performance (In Freescale Test Fixture, 50 ohm system) V_{DD} = 28 Vdc, I_{DQ} = 800 mA, P_{out} = 33 W Avg., Single-Carrier W-CDMA, IQ Magnitude Clipping, Input Signal PAR = 7.5 dB @ 0.01% Probability on CCDF. ACPR measured in 3.84 MHz Channel Bandwidth @ ±5 MHz Offset.

Frequency	G _{ps} (dB)	η _D (%)	Output PAR (dB)	ACPR (dBc)	IRL (dB)
920 MHz	20.1	34.6	6.3	-37.2	-14
940 MHz	20.0	34.3	6.3	-37.3	-24
960 MHz	19.8	34.2	6.3	-37.4	-20

1. MTTF calculator available at <http://www.freescale.com/rf>. Select Software & Tools/Development Tools/Calculators to access MTTF calculators by product.
2. Refer to AN1955, *Thermal Measurement Methodology of RF Power Amplifiers*. Go to <http://www.freescale.com/rf>. Select Documentation/Application Notes - AN1955.
3. Part internally matched both on input and output.

(continued)

Table 5. Electrical Characteristics ($T_A = 25^\circ\text{C}$ unless otherwise noted) (continued)

Characteristic	Symbol	Min	Typ	Max	Unit
Typical Performances (In Freescale Test Fixture, 50 ohm system) $V_{DD} = 28\text{ Vdc}$, $I_{DQ} = 800\text{ mA}$, 920-960 MHz Bandwidth					
P_{out} @ 1 dB Compression Point, CW	P1dB	—	120	—	W
IMD Symmetry @ 52 W PEP, P_{out} where IMD Third Order Intermodulation $\cong 30\text{ dBc}$ (Delta IMD Third Order Intermodulation between Upper and Lower Sidebands > 2 dB)	IMD _{sym}	—	16	—	MHz
VBW Resonance Point (IMD Third Order Intermodulation Inflection Point)	VBW _{res}	—	46	—	MHz
Gain Flatness in 40 MHz Bandwidth @ $P_{out} = 33\text{ W Avg.}$	G_F	—	0.3	—	dB
Gain Variation over Temperature (-30°C to $+85^\circ\text{C}$)	ΔG	—	0.016	—	dB/ $^\circ\text{C}$
Output Power Variation over Temperature (-30°C to $+85^\circ\text{C}$)	$\Delta P1\text{dB}$	—	0.002	—	dB/ $^\circ\text{C}$

Typical Broadband Performance — 880 MHz (In Freescale 880 MHz Test Fixture, 50 ohm system) $V_{DD} = 28\text{ Vdc}$, $I_{DQ} = 800\text{ mA}$, $P_{out} = 33\text{ W Avg.}$, Single-Carrier W-CDMA, IQ Magnitude Clipping, Input Signal PAR = 7.5 dB @ 0.01% Probability on CCDF. ACPR measured in 3.84 MHz Channel Bandwidth @ $\pm 5\text{ MHz}$ Offset.

Frequency	G_{ps} (dB)	η_D (%)	Output PAR (dB)	ACPR (dBc)	IRL (dB)
865 MHz	20.8	35.0	6.2	-37.1	-12
880 MHz	20.8	35.0	6.2	-37.5	-13
895 MHz	20.6	34.8	6.2	-38.0	-13

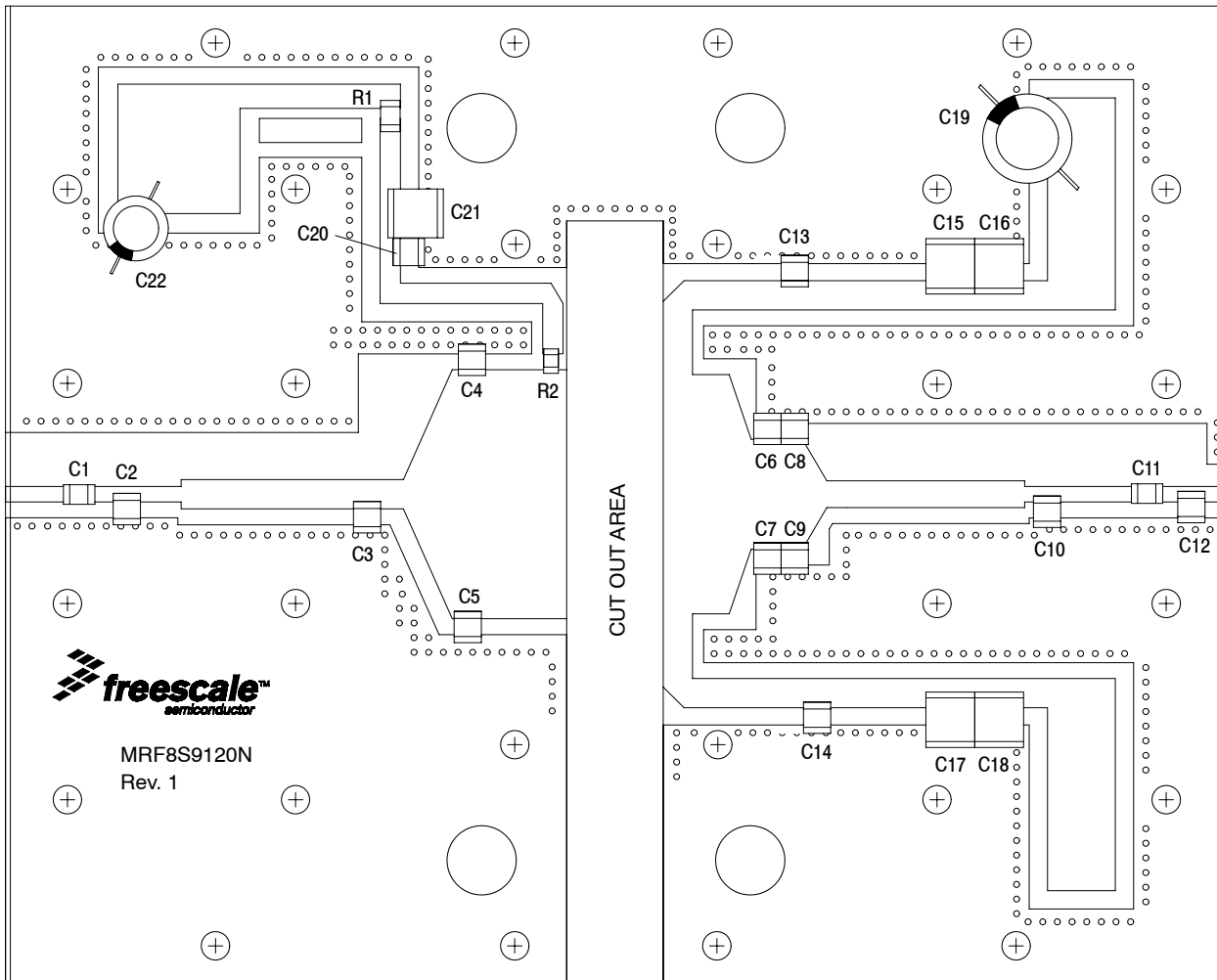


Figure 1. MRF8S9120NR3 Test Circuit Component Layout

Table 6. MRF8S9120NR3 Test Circuit Component Designations and Values

Part	Description	Part Number	Manufacturer
C1, C11, C20	39 pF Chip Capacitors	ATC100B390JT500XT	ATC
C2	1.8 pF Chip Capacitor	ATC100B1R8BT500XT	ATC
C3	2.0 pF Chip Capacitor	ATC100B2R0BT500XT	ATC
C4, C10	2.7 pF Chip Capacitors	ATC100B2R7BT500XT	ATC
C5	6.8 pF Chip Capacitor	ATC100B6R8CT500XT	ATC
C6, C7	7.5 pF Chip Capacitors	ATC100B7R5CT500XT	ATC
C8, C9	2.2 pF Chip Capacitors	ATC100B2R2JT500XT	ATC
C12	0.8 pF Chip Capacitor	ATC100B0R8BT500XT	ATC
C13, C14	43 pF Chip Capacitors	ATC100B430JT500XT	ATC
C15, C16, C17, C18, C21	10 μ F Chip Capacitors	GRM55DR61H106KA88L	Murata
C19	470 μ F, 63 V Chip Capacitor	MCGPR63V477M13X26-RH	Multicomp
C22	47 μ F, 50 V Chip Capacitor	476KXM050M	Illinois Capacitor
R1	3.3 Ω , 1/4 W Chip Resistor	P3.3VCT-ND	Panasonic
R2	10 Ω , 1/4 W Chip Resistor	CRCW120610R0JNEA	Vishay
PCB	0.030", $\epsilon_r = 3.5$	RF-35A2	Taconic

TYPICAL CHARACTERISTICS

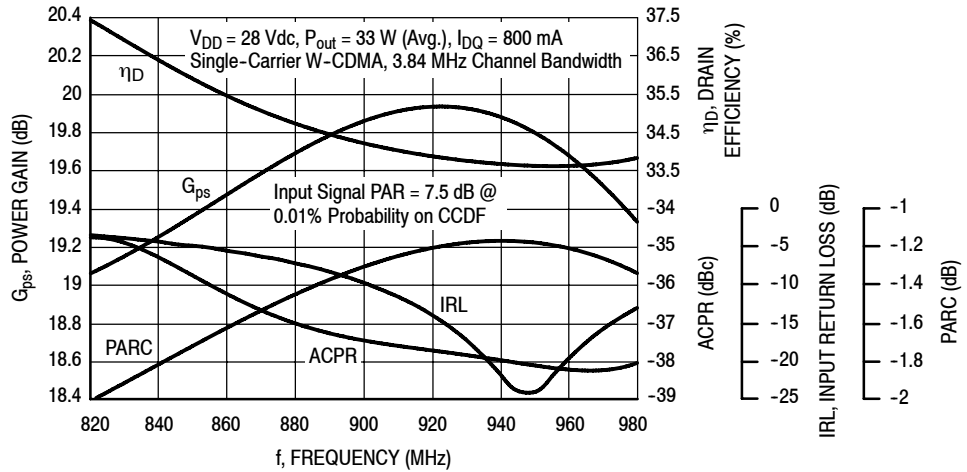


Figure 2. Output Peak-to-Average Ratio Compression (PARC) Broadband Performance @ $P_{out} = 33$ Watts Avg.

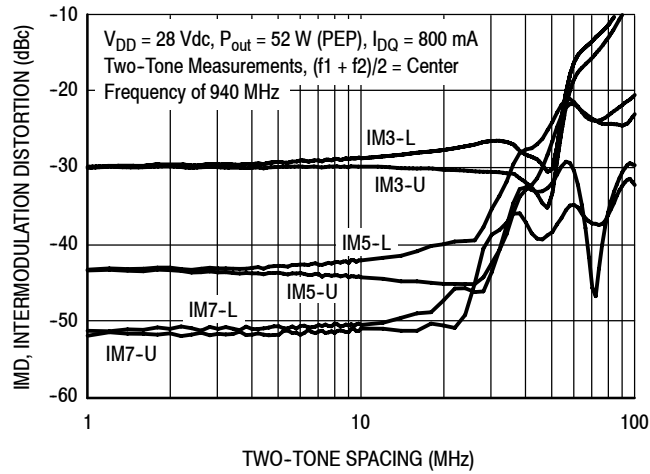


Figure 3. Intermodulation Distortion Products versus Two-Tone Spacing

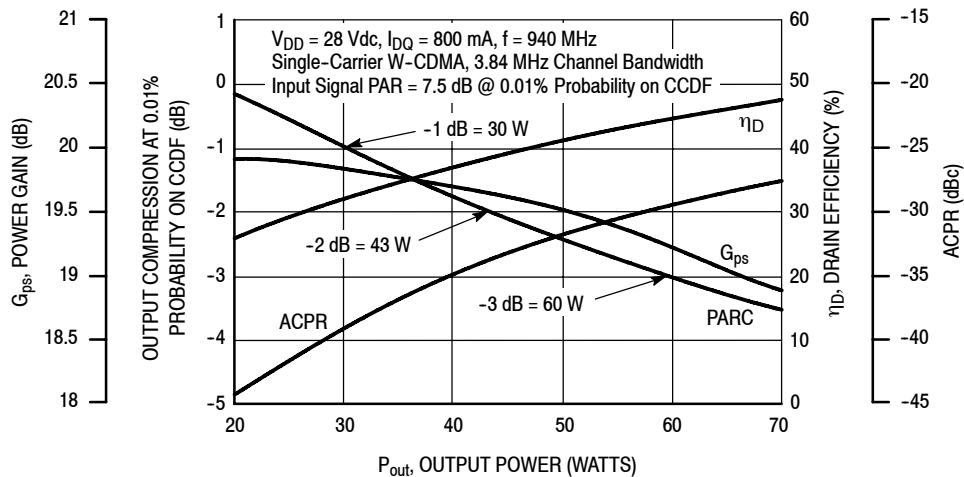


Figure 4. Output Peak-to-Average Ratio Compression (PARC) versus Output Power

TYPICAL CHARACTERISTICS

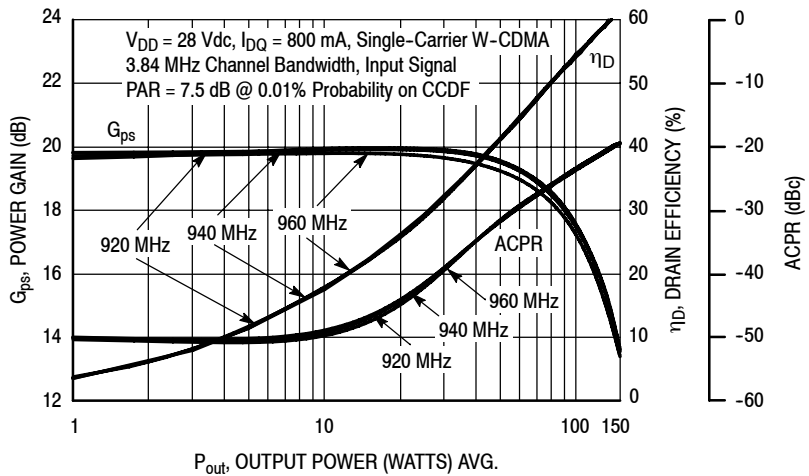


Figure 5. Single-Carrier W-CDMA Power Gain, Drain Efficiency and ACPR versus Output Power

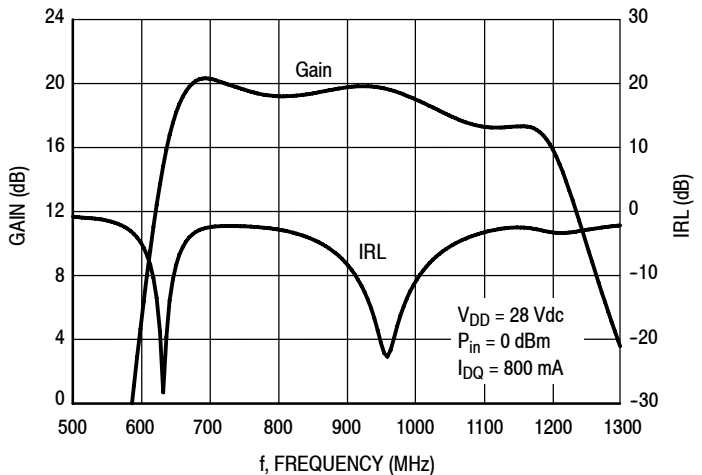


Figure 6. Broadband Frequency Response

W-CDMA TEST SIGNAL

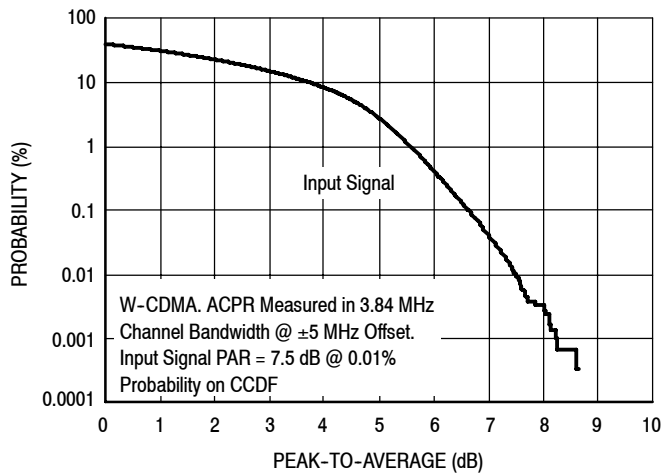


Figure 7. CCDF W-CDMA IQ Magnitude Clipping, Single-Carrier Test Signal

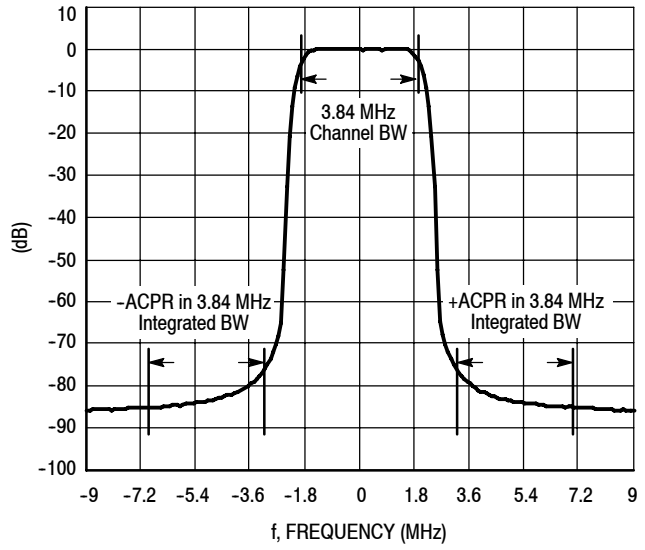


Figure 8. Single-Carrier W-CDMA Spectrum

$V_{DD} = 28 \text{ Vdc}$, $I_{DQ} = 800 \text{ mA}$, $P_{out} = 33 \text{ W Avg.}$

f MHz	Z_{source} Ω	Z_{load} Ω
820	$2.75 - j0.48$	$3.19 + j0.87$
840	$2.67 - j0.21$	$2.95 + j1.16$
860	$2.61 - j0.06$	$2.73 + j1.45$
880	$2.56 + j0.32$	$2.54 + j1.74$
900	$2.51 + j0.56$	$2.36 + j2.01$
920	$2.48 + j0.80$	$2.19 + j2.29$
940	$2.43 + j1.03$	$2.03 + j2.57$
960	$2.39 + j1.24$	$1.89 + j2.85$
980	$2.36 + j1.46$	$1.77 + j3.12$

Z_{source} = Test circuit impedance as measured from gate to ground.

Z_{load} = Test circuit impedance as measured from drain to ground.

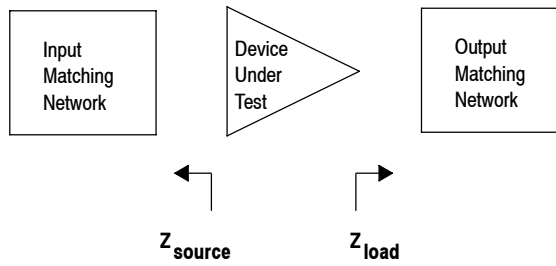
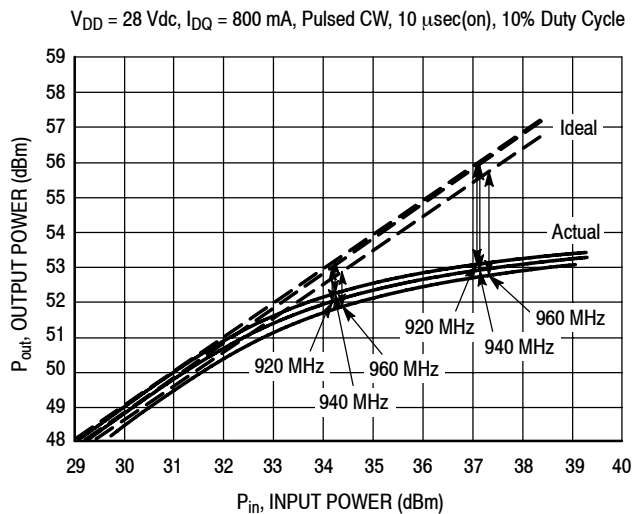


Figure 9. Series Equivalent Source and Load Impedance

ALTERNATIVE PEAK TUNE LOAD PULL CHARACTERISTICS



f (MHz)	P1dB		P3dB	
	Watts	dBm	Watts	dBm
920	168	52.3	202	53.1
940	160	52.0	195	52.9
960	154	51.9	188	52.7

Test Impedances per Compression Level

f (MHz)		Z_{source} Ω	Z_{load} Ω
920	P1dB	$1.45 - j2.02$	$1.28 - j2.39$
940	P1dB	$1.78 - j1.81$	$1.35 - j2.74$
960	P1dB	$1.78 - j2.35$	$1.33 - j2.99$

Figure 10. Pulsed CW Output Power versus Input Power @ 28 V

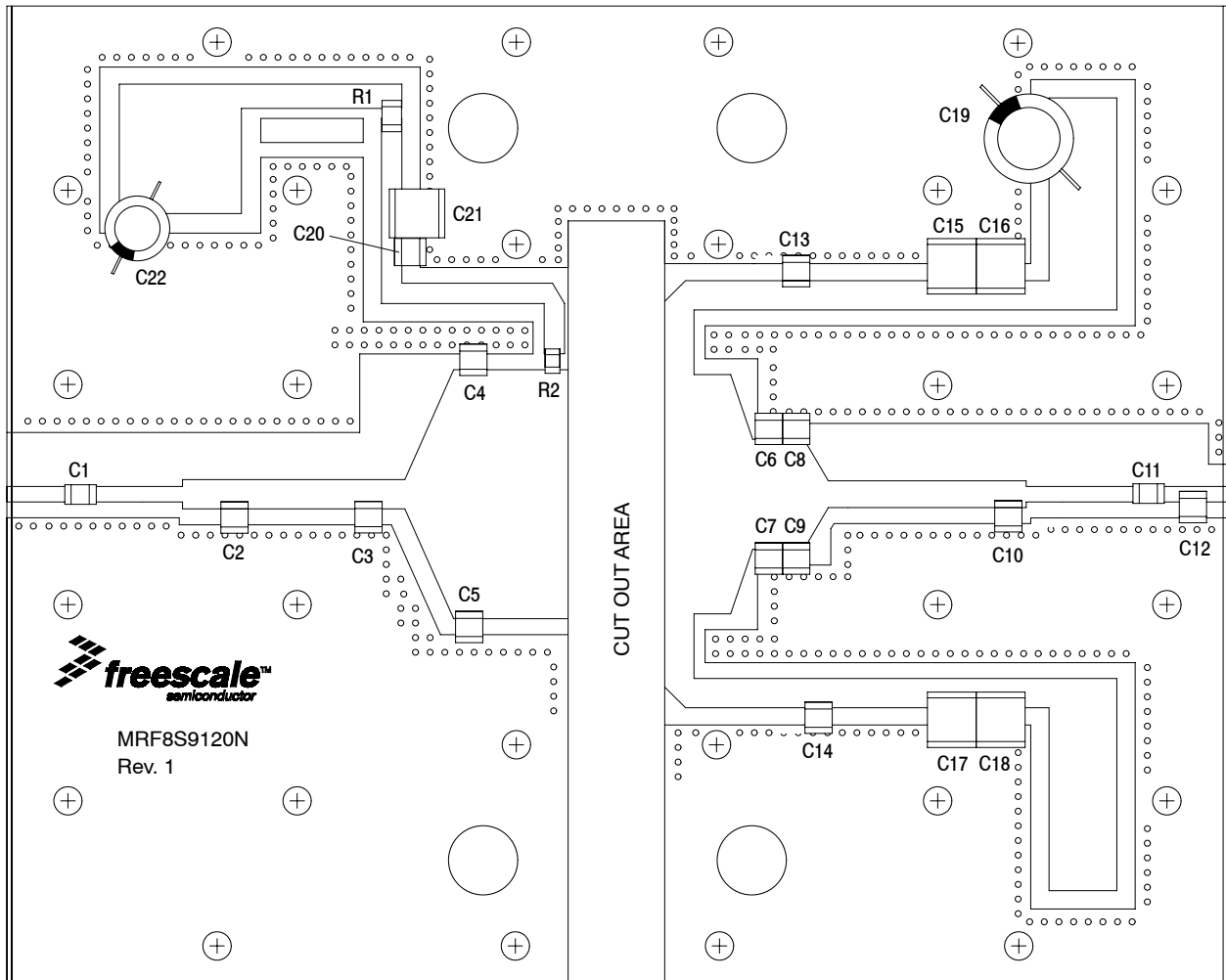


Figure 11. MRF8S9120NR3 Test Circuit Component Layout — 880 MHz

Table 7. MRF8S9120NR3 Test Circuit Component Designations and Values — 880 MHz

Part	Description	Part Number	Manufacturer
C1, C11, C20	47 pF Chip Capacitors	ATC100B470JT500XT	ATC
C2, C3, C4	3.3 pF Chip Capacitors	ATC100B3R3BT500XT	ATC
C5, C6, C7	7.5 pF Chip Capacitors	ATC100B7R5CT500XT	ATC
C8, C9	2.2 pF Chip Capacitors	ATC100B2R2JT500XT	ATC
C10	2.7 pF Chip Capacitor	ATC100B2R7BT500XT	ATC
C12	0.8 pF Chip Capacitor	ATC100B0R8BT500XT	ATC
C13, C14	43 pF Chip Capacitors	ATC100B430JT500XT	ATC
C15, C16, C17, C18, C21	10 μ F Chip Capacitors	GRM55DR61H106KA88L	Murata
C19	470 μ F, 63 V Electrolytic Capacitor	MCGPR63V477M13X26-RH	Multicomp
C22	47 μ F, 50 V Electrolytic Capacitor	476KXM050M	Illinois Capacitor
R1	3.3 Ω , 1/4 W Chip Resistor	P3.3VCT-ND	Panasonic
R2	10 Ω , 1/4 W Chip Resistor	CRCW120610R0JNEA	Vishay
PCB	0.030", $\epsilon_r = 3.5$	RF-35A2	Taconic

TYPICAL CHARACTERISTICS — 880 MHz

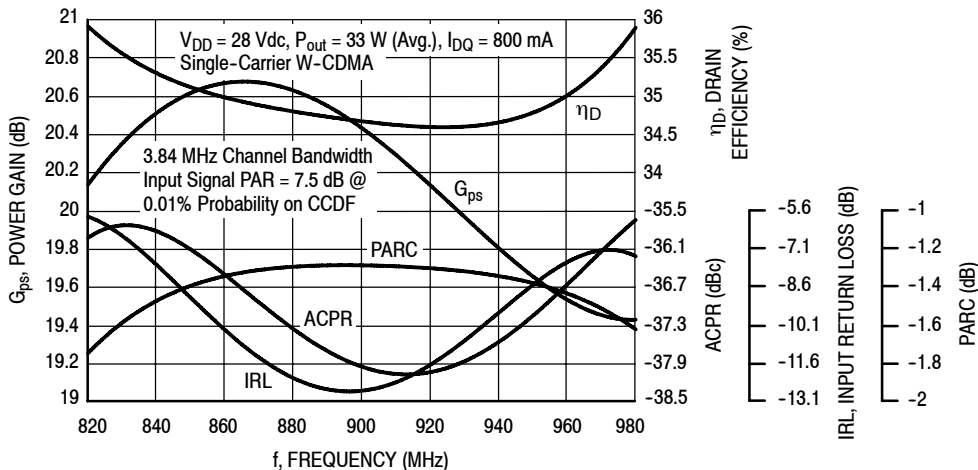


Figure 12. Output Peak-to-Average Ratio Compression (PARC) Broadband Performance @ P_{out} = 33 Watts Avg.

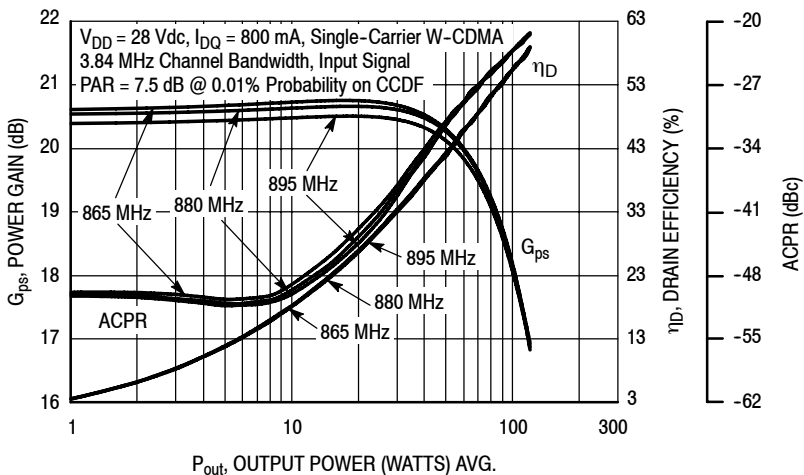


Figure 13. Single-Carrier W-CDMA Power Gain, Drain Efficiency and ACPR versus Output Power

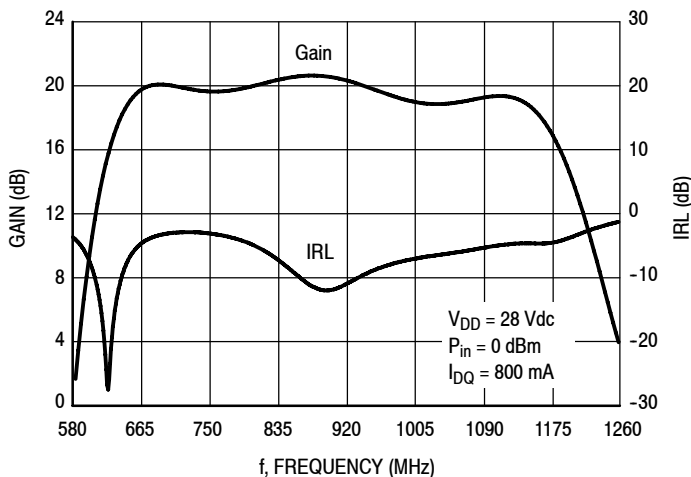


Figure 14. Broadband Frequency Response

$V_{DD} = 28 \text{ Vdc}$, $I_{DQ} = 800 \text{ mA}$, $P_{out} = 33 \text{ W Avg.}$

f MHz	Z_{source} Ω	Z_{load} Ω
820	$2.25 + j0.89$	$2.83 + j1.30$
840	$2.28 + j1.18$	$2.67 + j1.58$
860	$2.33 + j1.45$	$2.52 + j1.87$
880	$2.39 + j1.72$	$2.38 + j1.15$
900	$2.45 + j1.95$	$2.24 + j2.41$
920	$2.53 + j2.18$	$2.12 + j2.68$
940	$2.60 + j2.38$	$1.99 + j2.96$
960	$2.68 + j2.55$	$1.86 + j3.24$
980	$2.77 + j2.71$	$1.75 + j3.53$

Z_{source} = Test circuit impedance as measured from gate to ground.

Z_{load} = Test circuit impedance as measured from drain to ground.

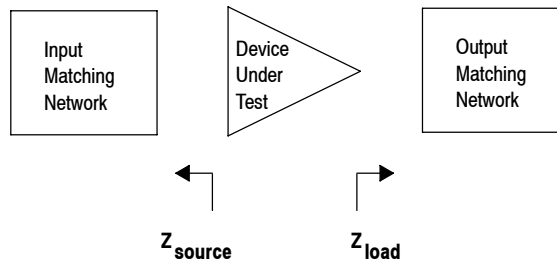
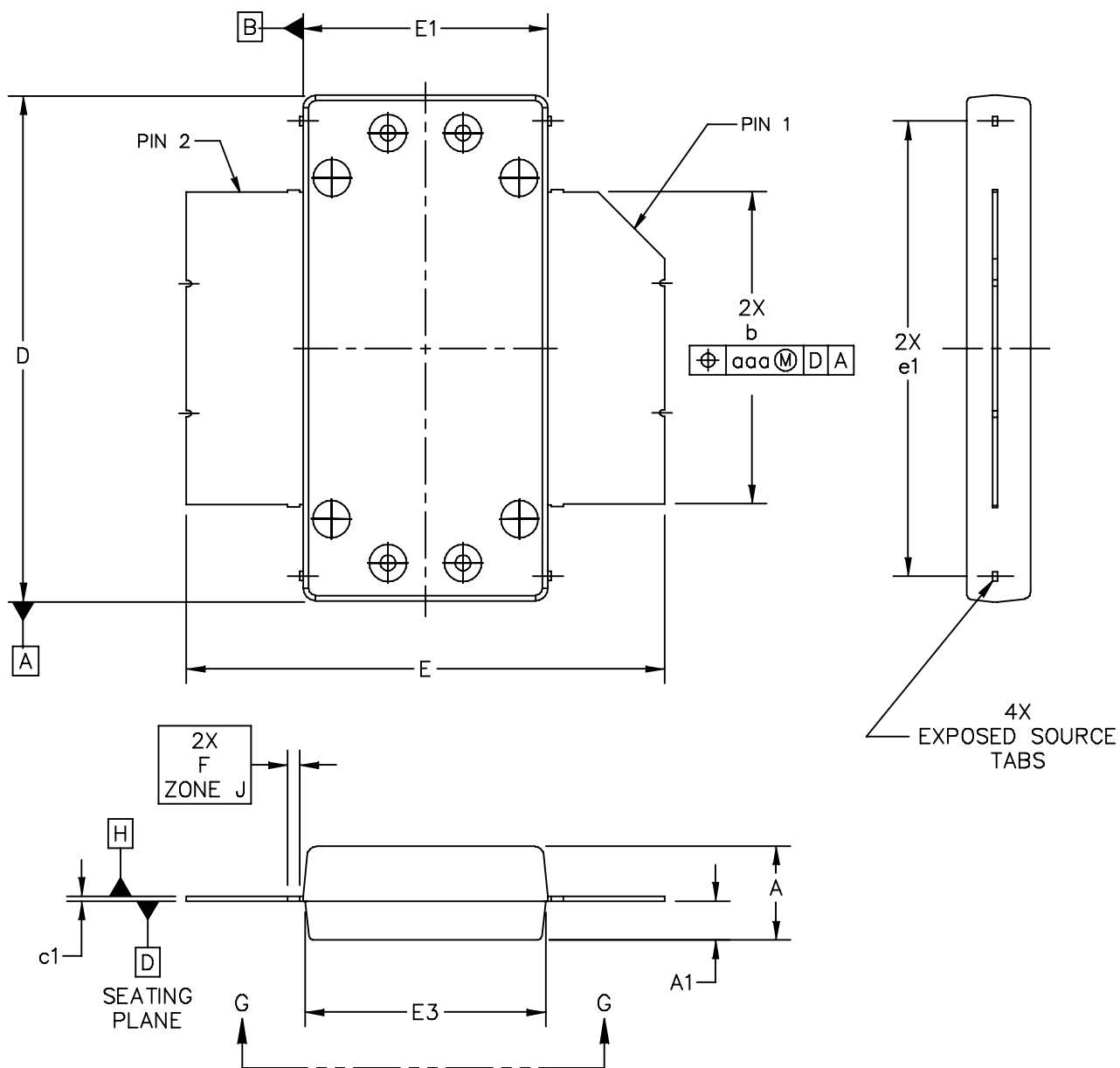
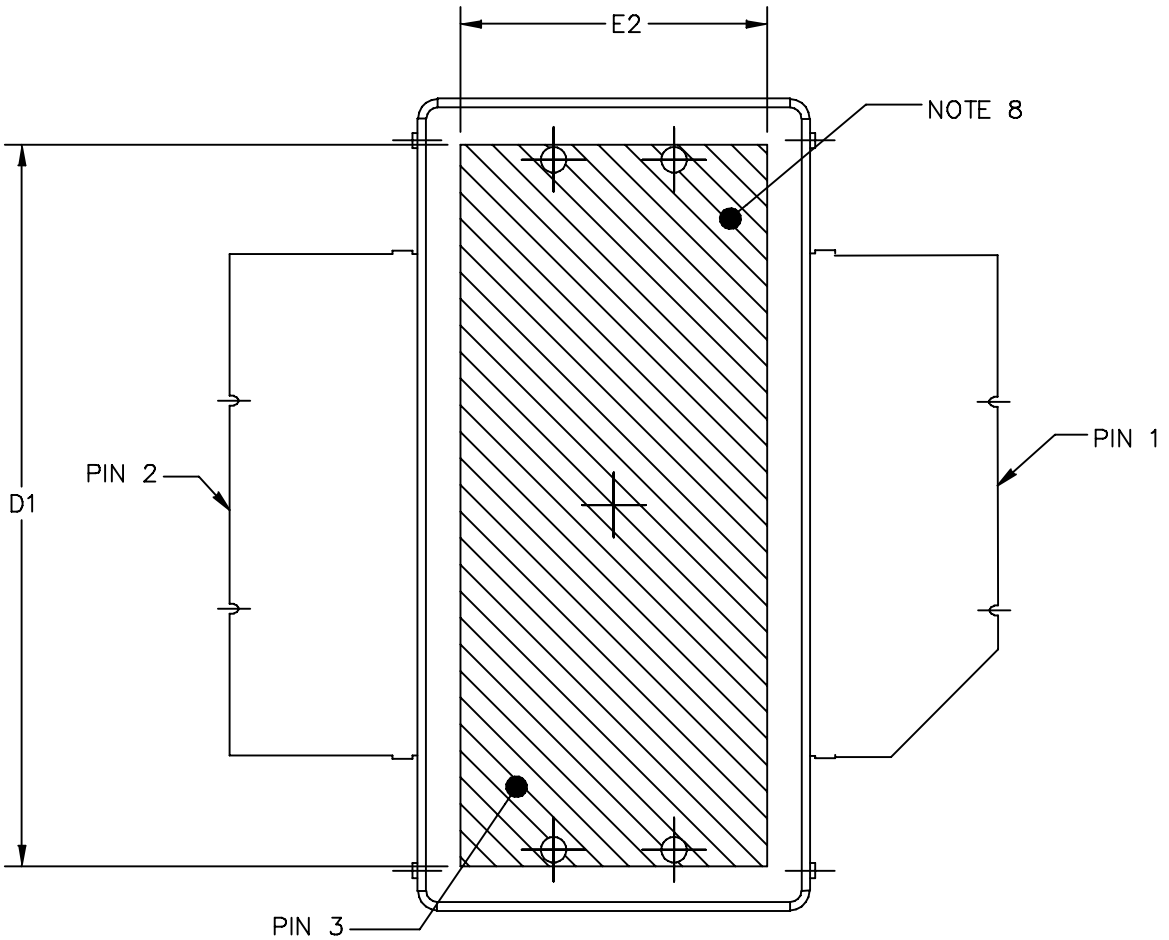


Figure 15. Series Equivalent Source and Load Impedance — 880 MHz

PACKAGE DIMENSIONS



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TITLE: OM780-2 STRAIGHT LEAD	DOCUMENT NO: 98ASA10831D	REV: B
	CASE NUMBER: 2021-03	22 OCT 2009
	STANDARD: NON-JEDEC	



BOTTOM VIEW
VIEW G-G

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TITLE: OM780-2 STRAIGHT LEAD	DOCUMENT NO: 98ASA10831D	REV: B	
	CASE NUMBER: 2021-03	22 OCT 2009	
	STANDARD: NON-JEDEC		

NOTES:

1. CONTROLLING DIMENSION: INCH
2. INTERPRET DIMENSIONS AND TOLERANCES PER ASME Y14.5M-1994.
3. DATUM PLANE -H- IS LOCATED AT TOP OF LEAD AND IS COINCIDENT WITH THE LEAD WHERE THE LEAD EXITS THE PLASTIC BODY AT THE TOP OF THE PARTING LINE.
4. DIMENSIONS "D" AND "E1" DO NOT INCLUDE MOLD PROTRUSION. ALLOWABLE PROTRUSION IS .006 PER SIDE. DIMENSIONS "D AND "E1" DO INCLUDE MOLD MISMATCH AND ARE DETERMINED AT DATUM PLANE -H-.
5. DIMENSION b DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE .005 TOTAL IN EXCESS OF THE b DIMENSION AT MAXIMUM MATERIAL CONDITION.
6. DATUMS -A- AND -B- TO BE DETERMINED AT DATUM PLANE -H-.
7. DIMENSION A1 APPLIES WITHIN ZONE "J" ONLY
8. HATCHING REPRESENTS THE EXPOSED AREA OF THE HEAT SLUG. THE DIMENSIONS D1 AND E2 REPRESENT THE VALUES BETWEEN THE TWO OPPOSITE POINTS ALONG THE EDGES OF EXPOSED AREA OF HEAT SLUG.

STYLE 1:

- PIN 1 - DRAIN
- PIN 2 - GATE
- PIN 3 - SOURCE

DIM	INCH		MILLIMETER		DIM	INCH		MILLIMETER	
	MIN	MAX	MIN	MAX		MIN	MAX	MIN	MAX
A	0.148	.152	3.76	3.86	b	.497	.503	12.62	12.78
A1	.059	.065	1.50	1.65	c1	.007	.011	0.18	0.28
D	.808	.812	20.52	20.62	e1	.721	.729	18.31	18.52
D1	.720	----	18.29	----					
E	.762	.770	19.36	19.56	aaa	.004		0.10	
E1	.390	.394	9.91	10.01					
E2	.306	----	7.77	----					
E3	.383	.387	9.73	9.83					
F	.025 BSC		0.635 BSC						
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					CASE NUMBER: 2021-03			22 OCT 2009	
					STANDARD: NON-JEDEC				

PRODUCT DOCUMENTATION AND SOFTWARE

Refer to the following documents, tools and software to aid your design process.

Application Notes

- AN1907: Solder Reflow Attach Method for High Power RF Devices in Plastic Packages
- AN1955: Thermal Measurement Methodology of RF Power Amplifiers
- AN3789: Clamping of High Power RF Transistors and RFICs in Over-Molded Plastic Packages

Engineering Bulletins

- EB212: Using Data Sheet Impedances for RF LDMOS Devices

Software

- Electromigration MTTF Calculator
- RF High Power Model
- .s2p File

For Software, do a Part Number search at <http://www.freescale.com>, and select the “Part Number” link. Go to the Software & Tools tab on the part’s Product Summary page to download the respective tool.

REVISION HISTORY

The following table summarizes revisions to this document.

Revision	Date	Description
0	Sept. 2010	• Initial Release of Data Sheet

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